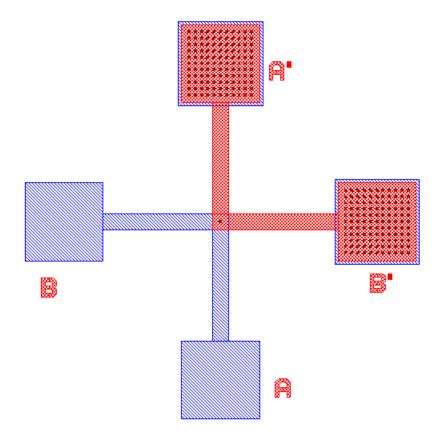
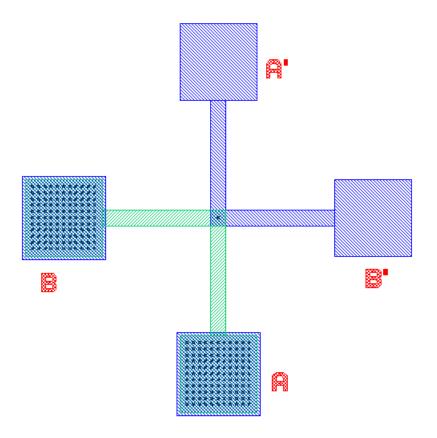
Single-Contact Resistance Test Structures

Important Details

- 17A: Metal/Poly-Si
 - 2 Poly-Si Line Segments -- Length: 160 μm; Width: 20 μm (1 square overlap w/contact)
- 17B: Metal/Diffused Si
 - 2 Diffused Si Line Segments -- Length: 160 μm; Width: 20 μm (1 square overlap w/contact)



17.(A) METAL-POLY CONTACT
RESISTANCE TEST STRUCTURE



17.(B) METAL-DIFFUSION CONTACT RESISTANCE TEST STRUCTURE

Masks: ACTV POLY CONT METL